Flat Panel Display Quality Assessment and Measurement

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Speaker Biography:
Raymond Ho received his Ph.D. in Colour Science from the University of Leeds. He is currently a researcher in Center for Measurement Standards of Industrial Technology Research Institute and working on a project of Flat Panel Display Image Quality Assessment Standardization. His current research is focused on the standards and metrology for FPD quality evaluation. He is a member of Semiconductor Equipment and Materials International (SEMI).